

Freescale SemiconductorMask Set Errata

KINETIS_L_1N97F Rev. 12 FEB 2013

Mask Set Errata for Mask 1N97F

Introduction

This report applies to mask 1N97F for these products:

KINETIS_L

Errata ID	Errata Title
3863	ADC: In 16-bit differential mode, ADC may result in a conversion error when positive input is near upper rail reference voltage
5751	FTFx: Launching the Read 1's Section command (RD1SEC) on an entire flash block results in access error (ACCER).
6070	I2C: Repeat start cannot be generated if the I2Cx_F[MULT] field is set to a non-zero value
5746	PIT: When using the PIT to trigger DMA transfers using cycle steal mode, two data transfers per request are generated
5666	PMC: Maximum current consumption in VLPR, VLPW, VLPS, LLS and VLLS modes may be higher than data sheet specification.
5667	PMC: When used as an input to ADC or CMP modules, the PMC bandgap 1-V voltage reference is not available in VLPx, LLS, or VLLSx modes
5472	SMC: Mode transition VLPR->VLLS0(POR disabled)->RUN, will cause POR & LVD.
5745	SPI1: Back to back DMA data transfers are not possible if the core:bus frequency ratio is greater than 4:1
5490	SPI1: DMA data transfers at the maximum baud rate can result in corrupted data
5515	TSI: The end of scan flag is not automatically cleared when continuously scanning
5744	UART0: Receiver wakeup control bit cannot be set immediately after a wakeup event
5563	UART0: When the Receiver Wake Up control bit is set, an IDLE condition is not detected correctly
5753	UART1 / UART2: When the Receiver Wake Up control bit is set, an IDLE condition is not detected correctly
5928	USBOTG: USBx_USBTRC0[USBRESET] bit does not operate as expected in all cases





e3863: ADC: In 16-bit differential mode, ADC may result in a conversion error when positive input is near upper rail reference voltage

Errata type: Errata

Description: In 16-bit differential mode, the ADC may result in a conversion error when the input voltage on

the plus-side of the differential pair (DPx) exceeds approximately (VREFH*31/32). Other

modes are unaffected.

Workaround: To avoid a conversion error near positive full-scale in this mode, do not allow the input voltage

on the plus-side of the differential pair (DPx) to exceed (VREFH*31/32).

e5751: FTFx: Launching the Read 1's Section command (RD1SEC) on an entire flash block results in access error (ACCER).

Errata type: Errata

Description: FTFx: Launching the Read 1's Section command on an entire flash block (i.e. with flash

address = flash block base address & number of longwords = total number of longwords in the

flash block) results in an incorrectly asserted access error (ACCER).

Workaround: To verify an entire flash block, use the Read 1's Block command. Use the Read 1's Section

command only to verify sections that are smaller than an entire flash block.

e6070: I2C: Repeat start cannot be generated if the I2Cx_F[MULT] field is set to a non-zero value

Errata type: Errata

Description: If the I2Cx_F[MULT] field is written with a non-zero value, then a repeat start cannot be

generated

Workaround: There are two possible workarounds:

1) Configure I2Cx_F[MULT] to zero if a repeat start has to be generated.

2) Temporarily set I2Cx_F [MULT] to zero immediately before setting the Repeat START bit in the I2C C1 register (I2Cx_C1[RSTA]=1) and restore the I2Cx_F [MULT] field to the original

value after the repeated start has occurred

e5746: PIT: When using the PIT to trigger DMA transfers using cycle steal mode, two data transfers per request are generated

Errata type: Errata

Description: If the PIT is used to trigger DMA transfers using cycle steal mode, DMA_DCRn[CS] = 1, each

transfer request will cause the source data to be written twice. The data will be written first to the desired destination address and then a second time to the destination address + 1. The

destination address pointer increments by 2 for each transfer request.

Workaround: It is recommended that the PIT not be used for triggering DMA transfers and the low power

timer (LPTMR) be used instead.



If it is required to use the PIT to trigger DMA transfers, the destination address must be in RAM and the buffer size must be twice the amount of data being transferred. Software must then skip every second entry in the destination buffer.

e5666: PMC: Maximum current consumption in VLPR, VLPW, VLPS, LLS and VLLS modes may be higher than data sheet specification.

Errata type: Errata

Description: Maximum current consumption in Very Low Power Run (VLPR), Very Low Power Wait

(VLPW), Very Low Power Stop (VLPS), Low Leakage Stop (LLS) ,Very Low Leakage Stop3 (VLLS3) ,Very Low Leakage Stop2 (VLLS2) ,Very Low Leakage Stop1 (VLLS1) , and Very Low Leakage Stop0 (VLLS0) modes within an operating range of -40°C to 25°C may exceed data

sheet specification.

Note: Some devices do not feature all of the power modes listed above. Refer to the Reference Manual to determine if a particular low power mode is available on your device.

Workaround: If maximum current consumption in these low power modes exceed system requirements, a higher power mode should be used.

e5667: PMC: When used as an input to ADC or CMP modules, the PMC bandgap 1-V voltage reference is not available in VLPx, LLS, or VLLSx modes

Errata type: Errata

Description: The Power Management Controller (PMC) bandgap 1-V reference is not available as an input

to the Analog-to-Digital Converter (ADC) module (using ADC input channel AD27) or the Comparator (CMP) module (using CMP input IN6) in Very Low Power Run (VLPR), Very Low Power Wait (VLPW), Very Low Power Stop (VLPS), Low Leakage Stop (LLS), Very Low Leakage Stop3 (VLLS3), Very Low Leakage Stop2 (VLLS2), Very Low Leakage Stop1

(VLLS1), or Very Low Leakage Stop0 (VLLS0) modes.

This erratum does not apply to the VREF module 1.2 V reference voltage.

Workaround: Use of the PMC bandgap 1-V reference voltage as an input to the ADC and CMP modules requires the MCU to be in Run, Wait, or Stop modes.

e5472: SMC: Mode transition VLPR->VLLS0(POR disabled)->RUN, will cause POR & LVD.

Errata type: Errata

Description: The Mode transition of VLPR into VLLS0 (POR disabled) then Exit, with LLWU event, back to

to RUN mode will cause a POR and LVD reset instead of the expected WAKEUP exit.

Workaround: The recommendation is to transition from VLPR to RUN before entering VLLS0 with POR

disabled mode.



e5745: SPI1: Back to back DMA data transfers are not possible if the core:bus frequency ratio is greater than 4:1

Errata type: Errata

Description: When using DMA with SPI1, if the core:bus frequency ratio is greater than 4:1

(SIM_CLKDIV1[OUTDIV4] greater than 3), the first data transfer in a sequence will be

transmitted twice.

This only applies to SPI1.

Workaround: When using DMA with SPI1, the core:bus frequency ratio must be 4:1 or less,

SIM CLKDIV1[OUTDIV4] must be less than 4.

If it is required to use SPI1 with core:bus frequency ratios greater than 4:1, an interrupt or

polling mechanism in software must be used.

e5490: SPI1: DMA data transfers at the maximum baud rate can result in corrupted data

Errata type: Errata

Description: DMA transfers of SPI1 data can result in corrupted data when the maximum baud rate is

selected for SPI1, SPI1 BR[SPPR] = 0 and SPI1 BR[SPR] = 0.

This only applies to SPI1.

Workaround: When using DMA to transfer Rx or Tx data for SPI1, the SPI1_BR[SPPR] and SPI1_BR[SPR]

fields must not both be written to 0.

If it is required to use SPI1 at the maximum baud rate, with SPI1_BR[SPPR] = 0 and SPI1_BR[SPR] = 0, an interrupt or polling mechanism in software must be used.

e5515: TSI: The end of scan flag is not automatically cleared when continuously scanning

Errata type: Errata

Description: The TSI requires the end of scan flag (TSIx_GENCS[EOSF]) to be cleared after each scan.

This prevents the out of range interrupt from being available in continuous scanning as each scan needs the TSIx_GENCS[EOSF] bit to be cleared by software. This limits the TSI from

providing an optimal low power wake-up capability.

Workaround: There are 3 workarounds that can be used depending on the application:

1. When the TSI is used in normal RUN mode without DMA, at the end of each scan, the TSIx_GENCS[EOSF] bit must be cleared by software. The end of scan can be detected either by polling the TSIx_GENCS[EOSF] bit or by enabling the end of scan interrupt.

2. When DMA is used, it can automatically clear the TSIx_GENCS[EOSF] bit after each scan. This can be used for run mode but not for low power mode.

3. Low power mode applications will have to wake-up on each end of scan, clear the TSIx GENCS[EOSF] bit and check the out of range flag to determine if touch has happened.



e5744: UART0: Receiver wakeup control bit cannot be set immediately after a wakeup event

Errata type: Errata

Description: The receiver wakeup control bit, UART0_C2[RWU], is cleared by hardware after a wakeup

event has occurred. After the UARTO C2[RWU] bit is cleared due to a wake up event,

software cannot set this bit for 3 asynchronous UART0 clock cycles.

Workaround: After a wakeup event, with UARTO C2[RWU] previously being set, software must wait 4 clock

cycles of the UART0 clock (selected by the SIM SOPT2[UART0SRC] field) before setting

UARTO C2[RWU].

UART0: When the Receiver Wake Up control bit is set, an IDLE condition is not e5563: detected correctly

Errata type: Errata

Description: An IDLE condition requires the receive line to become idle for a full character time, following a

period of activity (e.g. a character was received). The IDLE flag cannot become set again until

after a new character has been received.

The problem occurs when the Receiver Wake Up control bit is set, UARTO C2[RWU] = 1. In this case, an idle condition is detected whenever the receive line becomes idle for a full character time, regardless of whether a previous character is received or not. This can cause the UART0 C2[RWU] bit to clear (if UART0 C1[WAKE] = 0) and the UART0 S1[IDLE] flag to

set (if UARTO S2[RWUID] = 1) incorrectly.

This only applies to UART0.

Workaround: The UART0_C2[RWU] bit must only be set after a character has received and before the

UART0_S1[IDLE] flag is set. The UART0_C2[RWU] bit must not be set when the receive line

is already idle.

e5753: UART1 / UART2: When the Receiver Wake Up control bit is set, an IDLE condition is not detected correctly

Errata type: Errata

Description: An IDLE condition requires the receive line to become idle for a full character time, following a

period of activity (e.g. a character was received). The IDLE flag cannot become set again until

after a new character has been received.

The problem occurs when the Receiver Wake Up control bit is set, UARTx C2[RWU] = 1. In this case, an idle condition is detected whenever the receive line becomes idle for a full character time, regardless of whether a previous character is received or not. This can cause the UARTx_C2[RWU] bit to clear (if UARTx_C1[WAKE] = 0) and the UARTx_S1[IDLE] flag to

set (if UARTx_S2[RWUID] = 1) incorrectly.

This only applies to UART1 and UART2. The "x" in the register names refers to either UART1

or UART2.

Workaround: The UARTx_C2[RWU] bit must only be set after a character has received and before the

UARTx_S1[IDLE] flag is set. The UARTx_C2[RWU] bit must not be set when the receive line is already idle.



e5928: USBOTG: USBx_USBTRC0[USBRESET] bit does not operate as expected in all cases

Errata type: Errata

Description: The USBx_USBTCR0[USBRESET] bit is not properly synchronized. In some cases using the

bit can cause the USB module to enter an undefined state.

Workaround: Do not use the USBx_USBTCR0[USBRESET] bit. If USB registers need to be written to their

reset states, then write those registers manually instead of using the module reset bit.



How to Reach Us:

Home Page:

www.freescale.com

Web Support:

http://www.freescale.com/support

USA/Europe or Locations Not Listed:

Freescale Semiconductor
Technical Information Center, EL516
2100 East Elliot Road
Tempe, Arizona 85284
+1-800-521-6274 or +1-480-768-2130
www.freescale.com/support

Europe, Middle East, and Africa:

Freescale Halbleiter Deutschland GmbH
Technical Information Center
Schatzbogen 7
81829 Muenchen, Germany
+44 1296 380 456 (English)
+46 8 52200080 (English)
+49 89 92103 559 (German)
+33 1 69 35 48 48 (French)
www.freescale.com/support

Japan:

Freescale Semiconductor Japan Ltd. Headquarters ARCO Tower 15F 1-8-1, Shimo-Meguro, Meguro-ku, Tokyo 153-0064 Japan 0120 191014 or +81 3 5437 9125 support.japan@freescale.com

Asia/Pacific:

Freescale Semiconductor China Ltd.
Exchange Building 23F
No. 118 Jianguo Road
Chaoyang District
Beijing 100022
China
+86 10 5879 8000
support.asia@freescale.com

Information in this document is provided solely to enable system and software implementers to use Freescale Semiconductors products. There are no express or implied copyright licenses granted hereunder to design or fabricate any integrated circuits or integrated circuits based on the information in this document.

Freescale Semiconductor reserves the right to make changes without further notice to any products herein. Freescale Semiconductor makes no warranty, representation, or guarantee regarding the suitability of its products for any particular purpose, nor does Freescale Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any liability, including without limitation consequential or incidental damages. "Typical" parameters that may be provided in Freescale Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals", must be validated for each customer application by customer's technical experts. Freescale Semiconductor does not convey any license under its patent rights nor the rights of others. Freescale Semiconductor products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which failure of the Freescale Semiconductor product could create a situation where personal injury or death may occur. Should Buyer purchase or use Freescale Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify Freescale Semiconductor and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claims alleges that Freescale Semiconductor was negligent regarding the design or manufacture of

RoHS-compliant and/or Pb-free versions of Freescale products have the functionality and electrical characteristics as their non-RoHS-complaint and/or non-Pb-free counterparts. For further information, see http://www.freescale.com or contact your Freescale sales representative.

For information on Freescale's Environmental Products program, go to http://www.freescale.com/epp.

FreescaleTM and the Freescale logo are trademarks of Freescale Semiconductor, Inc. All other product or service names are the property of their respective owners.

© 2013 Freescale Semiconductor, Inc.



Document Number: KINETIS_L_1N97F

Rev. 12 FEB 2013

